

Single Switch IGBT Module

Replaces issue September 2003, version PDS5651-2.0

PDS5702-1.2 January 2004

FEATURES

- Trench Gate Field Stop Technology
- Low Conduction Losses
- Low Switching Losses
- 10µs Short Circuit Withstand

APPLICATIONS

- Motor Drives
- Wind Turbines
- UPS Systems

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 600V to 3300V and currents up to 3600A.

The DIM600BSS12-E000 is a single switch 1200V, n channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus full 10µs short circuit withstand.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM600BSS12-E000

Note: When ordering, please use the complete part number.

KEY PARAMETERS

V _{CES}		1200V
V _{CE(sat)}	(typ)	1.7V
I _C	(max)	600A
I _{C(PK)}	(max)	1200A

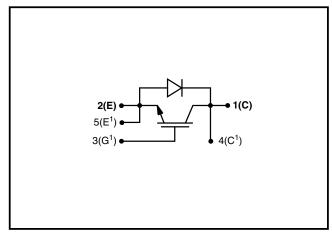


Fig. 1 Single switch circuit diagram



Fig. 2 Module Outline

Caution: This device is sensitive to electrostatic discharge. Users should follow ESD handling procedures.

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ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V _{CES}	Collector-emitter voltage	V _{GE} = 0V	1200	\ \
V _{GES}	Gate-emitter voltage	-	±20	V
I _c	Continuous collector current	$T_{case} = 80^{\circ}C$	600	А
I _{C(PK)}	Peak collector current	1ms, T _{case} = 110°C	1200	А
P _{max}	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 150^{\circ}C$	2.75	kW
l²t	Diode l²t value	$V_{R} = 0, t_{p} = 10 \text{ms}, T_{vj} = 125^{\circ}\text{C}$	45	kA²s
V _{isol}	Isolation voltage - per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	2.5	kV
Q_{PD}	Partial discharge - per module	IEC1287. V ₁ = 1300V, V ₂ = 1000V, 50Hz RMS	10	pC



THERMAL AND MECHANICAL RATINGS

Internal insulation: Al₂O₃ Clearance: 11mm

Baseplate material: Cu CTI (Critical Tracking Index): 425

Creepage distance: 20mm

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
$R_{\text{th(j-c)}}$	Thermal resistance - transistor	Continuous dissipation -	-	-	45	°C/kW
		junction to case				
$R_{th(j-c)}$	Thermal resistance - diode	Continuous dissipation -	-	-	80	°C/kW
		junction to case				
R _{th(c-h)}	Thermal resistance - case to heatsink	Mounting torque 5Nm	-	-	15	°C/kW
	(per module)	(with mounting grease)				
T _j	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	125	°C
T _{stg}	Storage temperature range	-	-40	-	125	°C
-	Screw torque	Mounting - M6	3	-	5	Nm
		Electrical connections - M6	2.5	-	5	Nm
		Electrical connections - M6	1.1		2	Nm



ELECTRICAL CHARACTERISTICS

 $T_{case} = 25$ °C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
I _{CES}	Collector cut-off current	$V_{GE} = 0V$, $V_{CE} = V_{CES}$	-	-	1	mA
		V _{GE} = 0V, V _{CE} = V _{CES} , T _{case} = 125°C	-	-	5	mA
I _{GES}	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$	-	-	2	μА
V _{GE(TH)}	Gate threshold voltage	$I_{\rm C} = 24 {\rm mA}, \ V_{\rm GE} = V_{\rm CE}$	5.0	5.8	6.5	V
V _{CE(sat)}	Collector-emitter saturation voltage	V _{GE} = 15V, I _C = 600A	-	1.7	2.15	V
		V _{GE} = 15V, I _C = 600A, , T _{case} = 125°C	-	2.0	2.5	V
I _F	Diode forward current	DC	-	-	600	А
I _{FM}	Diode maximum forward current	t _p = 1ms	-	-	1200	Α
V _F	Diode forward voltage	I _F = 600A	-	1.65	2.15	V
		I _F = 600A, T _{case} = 125°C	-	1.65	2.15	V
C _{ies}	Input capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz	-	42	-	nF
L _M	Module inductance - per arm	-	-	20	-	nH
R _{INT}	Internal transistor resistance	-	-	0.23	-	mΩ
SC _{Data}	Short circuit. I _{sc}	$T_j = 125^{\circ}C, V_{CC} = 900V,$ I_1	-	2400	-	Α
		$t_p \le 10\mu s$, $V_{CE(max)} = V_{CES} - L^*$. di/dt	-	-	-	Α
		IEC 60747-9				

Note:

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^{*} L is the circuit inductance + L_M



ELECTRICAL CHARACTERISTICS

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
t _{d(off)}	Turn-off delay time	I _C = 600A	-	550	-	ns
t _f	Fall time	$V_{GE} = \pm 15V$	-	100	-	ns
E _{OFF}	Turn-off energy loss	V _{CE} = 600V	-	62	-	mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 3.6\Omega$	-	200	-	ns
t,	Rise time	$R_{G(OFF)} = 1.8\Omega$	-	120	-	ns
E _{on}	Turn-on energy loss	L ~ 70nH	-	60	-	mJ
Q_g	Gate charge		-	6	-	μC
Q _{rr}	Diode reverse recovery charge	I _F = 600A, V _R = 600V,	-	45	-	μС
Irr	Diode reverse current	dl _F /dt = 4800A/μs	-	360	-	А
E _{REC}	Diode reverse recovery energy		-	18	-	mJ

T_{case} = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
t _{d(off)}	Turn-off delay time	I _C = 600A	-	700	-	ns
t _f	Fall time	$V_{GE} = \pm 15V$	-	150	-	ns
E _{OFF}	Turn-off energy loss	V _{CE} = 600V	-	95	-	mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 3.6\Omega$	-	250	-	ns
t,	Rise time	$R_{G(OFF)} = 1.8\Omega$	-	120	-	ns
E _{on}	Turn-on energy loss	L ~ 70nH	-	80	-	mJ
Q _{rr}	Diode reverse recovery charge	I _F = 600A, V _R = 600V,	-	90	-	μС
l _{rr}	Diode reverse current	dl _F /dt = 4400A/μs	-	440	-	Α
E _{REC}	Diode reverse recovery energy		-	36	-	mJ

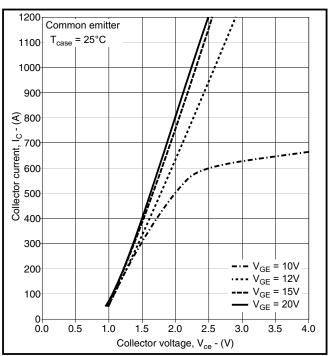
Note:

Switching Characteristic measurements taken using standard driver circuit conditions.

Caution: This device is sensitive to electrostatic discharge. Users should follow ESD handling procedures. **www.dynexsemi.com**



TYPICAL CHARACTERISTICS



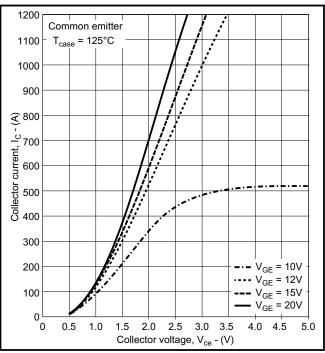
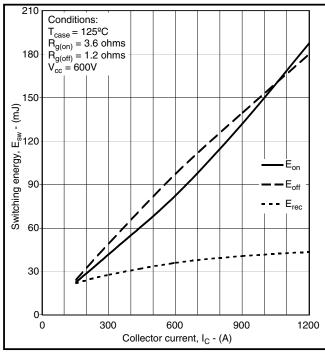


Fig. 3 Typical output characteristics

Fig. 4 Typical output characteristics





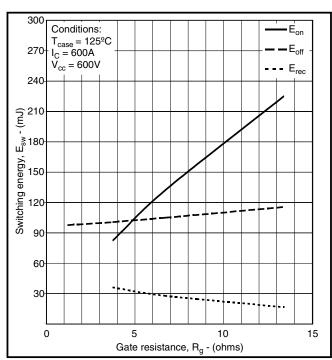
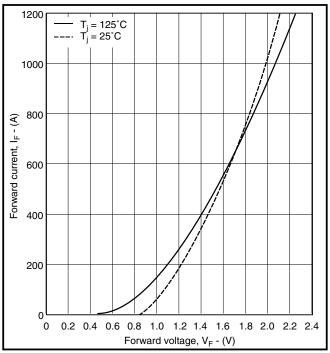


Fig. 6 Typical switching energy vs gate resistance

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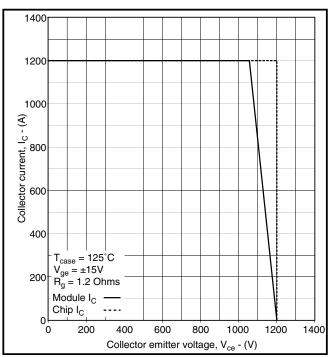


Fig. 8 IGBT reverse bias safe operating area

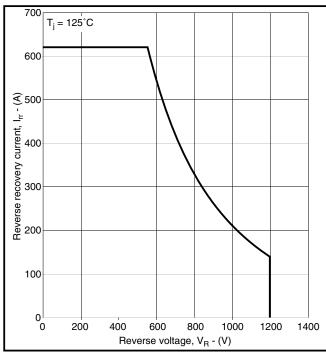


Fig. 9 Diode reverse bias safe operating area

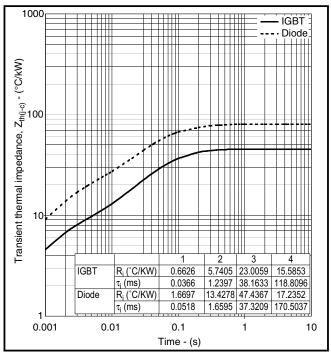


Fig. 10 Transient thermal impedance



PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.

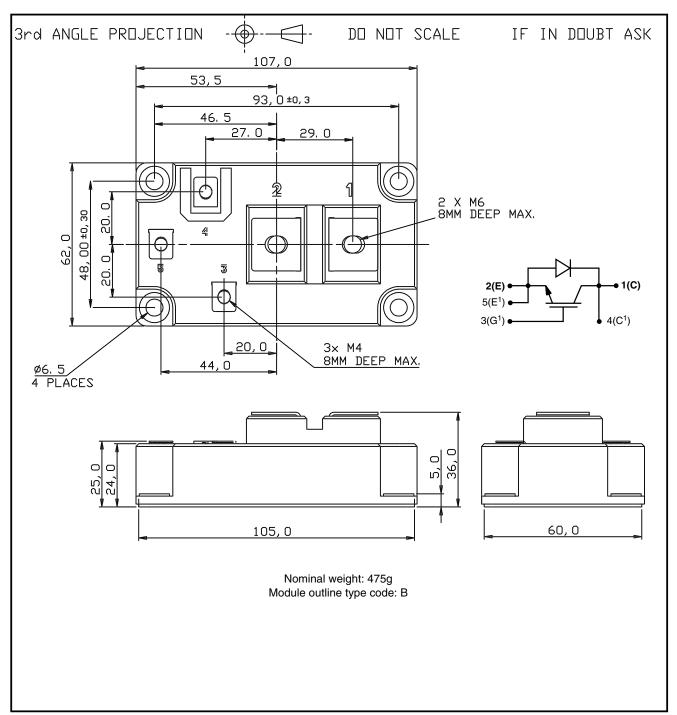


Fig. 11 Package details

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The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink and clamping systems in line with advances in device voltages and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group offers high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

HEATSINKS

The Power Assembly group has its own proprietary range of extruded aluminium heatsinks which have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or Customer Services.



http://www.dynexsemi.com

e-mail: power_solutions@dynexsemi.com

HEADQUARTERS OPERATIONS DYNEX SEMICONDUCTOR LTD

Doddington Road, Lincoln. Lincolnshire. LN6 3LF. United Kingdom. Tel: +44-(0)1522-500500

Tel: +44-(0)1522-500500 Fax: +44-(0)1522-500550 CUSTOMER SERVICE

Tel: +44 (0)1522 502753 / 502901. Fax: +44 (0)1522 500020

SALES OFFICES

Benelux, Italy & Switzerland: Tel: +33 (0)1 64 66 42 17. Fax: +33 (0)1 64 66 42 19.

France: Tel: +33 (0)2 47 55 75 53. Fax: +33 (0)2 47 55 75 59.

Germany, Northern Europe, Spain & Rest Of World: Tel: +44 (0)1522 502753 / 502901.

Fax: +44 (0)1522 500020

North America: Tel: (440) 259-2060. Fax: (440) 259-2059. Tel: (949) 733-3005. Fax: (949) 733-2986.

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